Application/Control No. Applicant(s)/Patent Under Reexamination 09/838,118 TAKANASHI ET AL Notice of References Cited Art Unit Examiner Page 1 of 1 1752 Sin J. Lee **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY 430/306 US-5,468,596 11-1995 Loerzer et al. Α US-4,716,094 12-1987 Minonishi et al. 430/284.1 В US-С D US-US-Ε F US-US-G USн US-

FOREIGN PATENT DOCUMENTS

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